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10/061,155	SHIRAIWA, YOSHIN	IOBU
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Class	Subclass	Date	Examiner
358	1.1, 1.15	7/20/2005	РКН
348	207.2	7/20/2005	РКН
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East Search	7/20/2005	РКН
Consultation with David Moore	7/20/2005	РКН
Consultation with 2600 Panel on U.S.C. 101	7/20/2005	PKH
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